PROCEEDINGS OF SPIE

Image Sensing Technologies: Materials, Devices, Systems, and Applications IV

Nibir K. Dhar
Achyut K. Dutta
Editors

12–13 April 2017
Anaheim, California, United States

Sponsored and Published by
SPIE

Volume 10209

Proceedings of SPIE 0277-786X, V. 10209

Image Sensing Technologies: Materials, Devices, Systems, and Applications IV,
edited by Nibir K. Dhar, Achyut K. Dutta, Proc. of SPIE Vol. 10209, 1020901
 · doi: 10.1117/12.2280646

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Author(s), "Title of Paper," in *Image Sensing Technologies: Materials, Devices, Systems, and Applications IV*, edited by Nibir K. Dhar, Achyut K. Dutta, Proceedings of SPIE Vol. 10209 (SPIE, Bellingham, WA, 2017) Seven-digit Article CID Number.

ISSN: 0277-786X
ISSN: 1996-756X (electronic)

ISBN: 9781510609198
ISBN: 9781510609204 (electronic)

Published by
SPIE
P.O. Box 10, Bellingham, Washington 98227-0010 USA
Telephone +1 360 676 3290 (Pacific Time) · Fax +1 360 647 1445
SPIE.org

Printed in the United States of America.

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